Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/622,044	KANO ET AL.
Examiner	Art Unit
Richard H. Kim	2871

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Text Search in 349/\$ (jpo,epo,uspat,pgpub-see printout)	1/19/2006	RJL		
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